Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/770,630	SHEN ET AL.
Examiner	Art Unit
Stephen J. Kalafut	1745

	SEARCHED					
Class	Subclass	Date	Examiner			
429	61, 62, 66, 137, 160, 161, 162	9/26/2006	SJK			
429	163, 176	9/26/2006	SJK			
429	211	9/26/2006	SJK			
429	231.3	9/26/2006	SJK			
429	223, 224	9/26/2006	SJK			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
eDAN Inventor Name Search	9/26/2006	SJK		